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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MSK		2003-005278	08.01.2003	JAPAN (w/Abstract)	G03B	21/00	Abstract	✓
MSK		2000-241874	08.09.2000	JAPAN (w/Abstract)	G03B	21/00	Abstract	✓
MSK		2001-186538	06.07.2001	JAPAN (w/Abstract)	H04N	9/31	Abstract	✓
MSK		2001-249401	14.09.2001	JAPAN (w/Abstract)	G03B	21/00	Abstract	✓
MSK		2002-262198	13.09.2002	JAPAN (w/Abstract)	H04N	5/74	Abstract	✓

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## U.S. PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

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**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)


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